SEP 2 0 2004

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

2829 1ah

In re Application

Inventors:

Charles A. Miller

SC/Serial No.: 10/749,358

Confirm. No.: 1180

Filed:

January 29, 2003

Title: INTEGRATED CIRCUIT TESTER WITH HIGH

BANDWIDTH PROBE ASSEMBLY

PATENT APPLICATION

Art Unit: 2829

Examiner: Jimmy Nguyen

Customer No. 23910

CERTIFICATE OF MAILING UNDER 37 C.F.R. § 1.8

I hereby certify that this correspondence is being deposited in the United States Postal Service with sufficient postage as first class mail in an envelope addressed to Commissioner for Patents, P.O. Box 1450 Alexandria, VA 22313-1450, on September 16, 2004.

Thomas A. Ward, Reg. No. 35,732 Signature Date: September 16, 2004

_(Attorney Signature)

RESPONSE TO OFFICE ACTION UNDER 37 C.F.R. § 1.111

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In response to the Office Action mailed June 16, 2004, please amend the aboveidentified application as indicated beginning on the following page.